Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10735680	NAKANO ET AL.	
Examiner	Art Unit	
Franklin, Richard	2181	

	SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES				
Search Notes	Date	Examiner		
Updated EAST Search	4/6/07	RBF		
PLUS 2.0 Search	4/4/07	RBF		
Alan Chen (Patent Examiner; AU 2182; 710/1-74)	4/5/07	RBF		
David Martinez (Patent Examiner; AU 2181; 710/1-74)	4/5/07	RBF		
Inventor Name Search	4/3/07	RBF		
365/200; 710/1,5-7; 711/103,164,167,170 (Limited EAST Text Search)	4/6/07	RBF		

	INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner		

Part of Paper No.: 20070406